Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/073,106	YAMAMOTO ET AL.
Examiner	Art Unit
Paul D. Kim	3729

SEARCHED				
Class	Subclass	Date	Examiner	
29	831 832 840 841 844 846 851 854	6/30/2005	PK	
156	64 356			
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228	175 227	6/30/2005	PK	
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174	259 260	7/1/2005	PK	
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257	686 778			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	DATE	EXMR
Text Search EAST/NPL (IEEE)	7/1/2005	PK
Consulted by John Vigushin (361)	2/1/2006	PK
Scott Geyer (438)	2/2/2006	PK
Updated Text Search EAST	2/2/2006	PK
Updated Text Search EAST	5/16/2006	PK